

Search Notes

Application/Control No.

10/826,407

Examiner

Winnie Yip

Applicant(s)/Patent under
Reexamination

SMITH ET AL.

Art Unit

3636

SEARCHED

Class	Subclass	Date	Examiner
52	68 79.1 79.9	11/11/2005	WSY
	79.12		
	79.13 143		
	264-265		
	270-272		
	282.3		
	282.4 459		
	464 468		
	582.1		
	653.1		
296	29 24.3		
	168 171		
	203 210		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
52	79.9 143	11/11/2005	WSY
52	169.12		
52	582.1		
52/282.4; 296/29, 210			

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Searched in EAST	11/11/2005	WSY